FORM PTO 1449 (modified)			ATTY DOCKET NO.	APPLICATION N	10.	<del></del>	
U.S. DEPARTMENT OF COMMERCE			862.C2170	09/819,907	7		
PATENT AND TRADEMARK OFFICE PE			APPLICANT				
	OF REFERENCES CITED BY APP	-24	Haruhiro ONO, et al.				
	Use several sheets if necessary 2 3 2001		FILING DATE				
Date Submitted	to PTO: October 23, 2001/2	S. 31	March 29, 2001	March 29, 2001			
		TRADERIE TRADERIE	U.S. PATENT DOCUMENTS			*	
*EXAMINER	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
INITIAL						IF APPROPRIATE	
LAV	5,834,783	11/10/1998	Muraki, et al.	250	398		
	5,864,142	01/26/1999	Muraki, et al.	250	491.1		
	5,905,267	05/18/1999	Muraki	250	492.22		
	5,981,954	11/09/1999	Muraki	250	397		
	6,107,636	08/22/2000	Muraki	250	492.2		
	6,104,035	08/15/2000	Muraki	250	492.22		
	6,166,387	12/26/2000	Muraki, et al.	250	492.2		
	5,929,454	07/27/1999	Muraki, et al.	250	491.1		
	5,939,725	08/17/1999	Muraki	250	492.22		
	5,973,332	10/26/1999	Muraki, et al.	250	492.2		
1	6,137,113	10/24/2000	Muraki	250	492.22		
M	4,419,580	12/06/1983	Walker, et al.	250	396 R		
	· · · · · · · · · · · · · · · · · · ·	FC	DREIGN PATENT DOCUMENTS				
	†					TRANSLATION	
	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	YES/NO/	
	NUMBER					OR ABSTRACT	
		OTHER DOCUMENT(S)	Including Author, Title, Date, Pertiner	nt Pages, Etc.)		···	
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Sheet 1 of 2

FORM PTO 1449 (modified), U.S. DEPARTMENT OF COMMERCE PE PATENT AND TRADEMARK OFFICE PE		PE	ATTY DOCKET NO. 862.C2170	APPLICATION NO 09/819,907	APPLICATION NO. 09/819,907			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			APPLICANT Haruhiro ONO, et al.					
	Date Submitted to PTO: October 23, 2001		FILING DATE March 29, 2001		GROUP 2879			
	- W	G TRADEMAN	U.S. PATENT DOCUMENTS					
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
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		FC	PREIGN PATENT DOCUMENTS	1				
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT		
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	(	OTHER DOCUMENT(S)	Including Author, Title, Date, Pertine	ent Pages, Etc.)		100		
"Sub-Nanometer Miniature Electron Microscope", A.D. Feinerman, et al., Journal of Vacuum Science and Technology A, Vol. 10, No. 4, July/August 1992, 611-616.								
M		"High Aspect Ratio Aligned Multilayer Microstructure Fabrication", K. Y. Lee, et al., Journal of Vacuum Science and Technology B, Vol. 12, No. 6, November/December 1994, pp. 3425-3430.						
PA		"Arrayed Miniature Electron Beam Columns For High Throughput Sub-100 nm Lithography", T. H. P. Chang, et al., Journal of Vacuum Science and Technology B, Vol. 10, No. 6, November/December 1992, pp. 2743-2748.						
A		"Microstructures for Particle Beam Control", G. W. Jones, et al., Journal of Vacuum Science and Technology B, Vol. 6, No. 6, November/December 1988, pp. 2023-2027.						
PAV		"A Multibeam Scheme for Electron-Beam Lithography", T. Sasaki, Journal of Vacuum Science and Technology, Vol. 19, No. 4, November/December 1981, pp. 963-965.						
EXAMINER /			DATE CONSIDERED 7	DATE CONSIDERED 7/30/03				

\*EXAMINER: Ipitial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered.

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| Sheet 2 of 2 |

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U.S. DEPARTMENT OF COMMENT PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)

ATTY DOCKET NO. 00862.022170

APPLICATION NO. 09/819,907

APPLICANT Haruhiro ONO et al.

FILING DATE March 29, 2001

GROUP 2879

January 29, 2003			FILING DATE March 29, 2001		GROUP 2879		
		(	J.S. PATENT DOCUMENTS		T		
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
IM	5,121,234	06/09/1992	Kucera	359	50		
	5,604,394	02/18/1997	Saito et al.	313	422		
	6,381,702	04/30/2002	Ogasawara	713	500		
MA	2002/0051111	05/02/2002	Greene et al.	349	149	···	
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FORM PTO 1449	(modified)		ATTY DOCKET NO. 00862.022170	APPLICA'	TION NO. 09/8	18,907	
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LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)  March 5, 2003			FILING DATE March 29, 2001		GROUP 2879		
	Waron 6, 2000		J.S. PATENT DOCUMENTS				
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE	
A	5,121,234	06/09/1992	Kucera	359	50		
	5,604,394	02/18/1997	Saito et al.	313	422		
	6,381,072	04/30/2002	Ogasawara	713	500		
DN	2002/0051111	05/02/2002	Greene et al.	349	149	<u></u>	
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